Identifying the Best Fit Failure Distribution and the Parameters of Machine's Component: A New Approach

Rosmaini Ahmad, Shahrul Kamaruddin, Mohzani Mokthar and Indra Putra Almanar

School of Mechanical Engineering, Engineering Campus, Universiti Sains Malaysia, 14300 Nibong Tebal, Pulau Pinang, MALAYSIA.

rosmainibinahmad@yahoo.com, meshah@eng.usm.my, mohzani@eng.usm.my, meinput@eng.usm.my

Abstract

In industries, failure of the equipment to function became a major contribution to the production losses and high maintenance cost. Therefore, there is a need to have an optimal maintenance strategy such as replacement, repair and inspection. Before any optimal maintenance strategy can be implemented failure distribution and the parameters of the machine's component need to be identified. Therefore, the main objective in this paper is to propose a new approach in applying the Least-Squares Curve-Fitting (LSCF) and Maximum Likelihood Estimator (MLE) techniques in identifying the failure distribution and the parameters of machine's component. The new approach proposed can assist maintenance engineers to make more precise identification in failure data analysis as well as in maintenance optimisation analysis. The paper starts by introducing the application of LSCF and MLE techniques to identify the best failure fit distribution and its parameters. It follows by numerical examples to determine whether the best fit failure distribution and its parameters are applicable to be applied in maintenance optimisation analysis. This is carried out by comparing the proposed new approach with a case study from the literature.

Keywords

Failure time, Least-Squares Curve-Fitting, Maximum Likelihood Estimator, Best fit Failure Distribution and Its Parameters.

1. Introduction

In reliability and maintainability study, the characteristic of the equipment lifetime will go through decreasing, constant and increasing failure rate at the beginning, middle and final life, respectively. These characteristics can be presented via the failure distribution of the equipment. There are many types of failure distribution used in reliability analysis such as exponential, weibull, normal and lognormal distributions. In the application of maintenance optimisation, the failure distribution of the equipment must be specified before any maintenance strategy is carrying out. Wrong identification of failure distribution will affects the cost of maintenance and lost of production. For example, preventive replacement (PR) strategy to be worthwhile only if the failure rate of the equipment is increase [2]. If the PR strategy is carried out at decreasing or constant failure rate, the replacement and downtime cost will significantly increase by time. The increasing failure rate can be presented by weibull, normal and lognormal distributions, whereas exponential distribution shows the constant failure rate. Maillart and Pollock, 1999 [5] study on the consequences of mis-specifying the form of the failure distribution of inspection strategy. From the analysis, they indicated that if the failure distribution incorrectly specified the long run expected cost per unit time will significantly increase.

In the process of failure distribution identification, the Least-Squares Curve-Fitting (LSCF) and Maximum Likelihood Estimator (MLE) techniques are widely used [1]. The LSCF technique is used for specifying the best fit failure distribution and MLE technique is used to determine the parameters of distribution. In traditional approach, the LSCF is used to specify the best fit failure distribution with testing of each failure distribution models (exponential, weibull, normal and lognormal). Then, MLE technique is applied to determine the parameters of distribution. Traditional approach suggest complicated steps in identifying the best failure time distribution, which is calculated for every distribution test procedures using LSCF before the distribution parameters can be determined using MLE. In this paper, the new approach is proposed to reduce the calculations steps. The basic idea in a new approach is determines only the shape parameter, β of weibull distribution using LSCF technique. The value of shape parameter, β can be used to specify the best fit failure distribution before its parameters can be estimated using MLE technique.

2. Data Collection

The failure data is a set of failure time of the component. This failure time is always referred to Time Between Failure (TBF) of the component. TBF is measure from the time after a new component was installed until the time of next failure occurs. The measurement unit of TBF can be in operating hours, day and cycle. Figure 1 showed the graphical view of a set of TBF of the component in interval (t_1, t_2) .



Figure 1 - Time between Failures (TBF) of the component

The symbol of x_i , shows the length of operating time (TBF) and i, is the number of failure time (number of data) at interval (t₁, t₂), which values of x are random. The length of operating time (TBF) depends on the type and how the component is designed and used.

3. Identification the Best Fit Failure Distribution and Its Parameters

Least-Squares Curve-Fitting (LSCF) technique is widely used for identifying the best fit distribution of failure time. The Maximum Likelihood Estimator (MLE) is used to identify the parameters of the distribution. The main objective in this paper is to propose a new approach by using LSCF and MLE in determination the best failure fit distribution and its parameters. The main advantage of the new approach is reduce the steps in determining the best fit distribution. Figure 2 showed the comparison in term of calculation steps between the traditional approach and the new approach proposed in this paper.

Referring to figure 2, traditional approach generally has five steps in determining the best fit distribution and its parameters. In traditional approach, exponential, weibull, normal and lognormal distribution tests are used respectively to determine the best fit distribution. All these steps are under Least-Squares Curve-Fitting (LSCF) technique. In LSCF technique, the index of fit, r will be compared between exponential, weibull, normal and lognormal distribution tests. The higher value of r near to 1 will be selected as the best fit distribution. The last step (step number five) in the traditional approach is parameters estimation of best fit distribution using Maximum Likelihood Estimator (MLE) technique.

However, in the new approach, only two steps are needed to identify the best failure fit distribution and its parameter. First step is to determine the shape parameter, β of weibull distribution using LSCF. The values of shape parameter, β shows the best distribution of failure time, as shown in figure 2; a new approach. Second step is estimating the distribution parameters depending on the shape parameter, β of weibull test using MLE. Following section present the calculation to determine the best fit distribution and its parameters for traditional approach and the new approach.

3.1 Traditional Approach

Fit Distribution Test - Least-Squares Curve-Fitting (LSCF) Technique

In the LSCF technique, a set of failure data will be arranged in a cumulative form. For example, if the failure time is assume to be a complete data (not censored), where the values are; 235, 259, 367, 214, 402, 115 and 98. The cumulative form of these failure times is 98, 115, 214, 235, 259, 367 and 402. Where n, is the total number of failure time and t_i indicates the failure time and i, is the number of failure from minimum to maximum values. Then, three basic variables; cumulative function $F(t_i)$, x_i and y_i axis are determined for each distribution (exponential, weibull, normal and lognormal). The value of cumulative function, $F(t_i)$ of each failure time can be determined using equation (1).

$$F(t_i) = \frac{(i-0.3)}{(n+0.4)} \tag{1}$$

While, the values of x_i and y_i axis can be determined using the formula tabulated in table 1.

Table 1- The value of x_i *and* y_i *axis of the failure time*

Distribution	Step	Xi	yi
Exponential	1	ti	$\ln[1/(1 - F(t_i)]]$
Weibull	2	lnt _i	$\ln \ln [1/(1 - F(t_i))]$
Normal	3	ti	$z_i = \Phi^{-1}[F(t_i)] = (t_i - \mu^*)/\sigma^*$
Lognormal	4	ti	$z_i = \Phi^{-1}[F(t_i)] = (lnt_i/\sigma^*)$ -
			$(lnt_i/\sigma *)$

Where, μ^* and σ^* is the initial value of mean and standard deviation of the sample, respectively. Each of these values can be determined using equation (2) and (3).

$$\mu^* = \sum_{i=1}^n \frac{t_i}{n}$$

$$\sigma^* = \frac{\sum_{i=1}^n t^2 - n(\mu^*)^2}{n-1}$$
(2)
(3)

Finally, the index of fit, r is determined for each distribution test. The index of fit, r can be calculated using equation (4) [4]. The index of fit, r is compared between exponential, weibull, normal and lognormal distribution tests, which the higher value of, r will select as the best fit failure distribution. The parameters estimation is based on the distribution that chosen from the higher index of fit, r.

$$r = \frac{\left(\sum_{i=1}^{n} x_{i} y_{i} - \left(\sum_{i=1}^{n} x_{i} \sum_{i=1}^{n} y_{i}\right)/n\right)^{2}}{\left(\sum_{i=1}^{n} x^{2} - \left(\sum_{i=1}^{n} x_{i}\right)^{2}/n\right)\left(\sum_{i=1}^{n} y^{2} - \left(\sum_{i=1}^{n} y_{i}\right)^{2}/n\right)}$$
(4)

Parameter Estimation - Maximum Likelihood Estimator (MLE) technique

Until the parameters are determined, the distribution is not completely specified [1]. Hence, the next step (step five) is to estimate the parameters of the distribution (highest index of fit, r) using Maximum Likelihood Estimator (MLE) technique. Each distribution has their particular parameters and it will be determined in different way. Table 2 shows the particular parameters of each distribution and their formula.



Figure 2 – Comparison between traditional approach and a new approach in determination the best fit failure distribution and it parameters

3.2 Traditional Approach

In the new approach it only used two steps for determining the best fit distribution and its parameters. Like the traditional approach, Least-Squares Curve-Fitting (LSCF) test is used in the process of identifying the best fit distribution. The basic idea in the new approach is determine the shape, β of weibull distribution. Theoretically, the shape parameter, β for weibull distribution presents different failure distribution depends on the value of, β (refer to figure 2 – a new approach) [1]. For example, if the value of shape parameter, β is between $3 \le \beta \le 4$, the failure time follows the normal distribution trend. The cumulative form (equation (1)) and the values of x_i and y_i axis for weibull test (table 1) are used to determine shape parameter, β of weibull distribution. The value of β can be determined using equation (5) below;

$$\beta = \frac{\sum_{i=1}^{n} x_i y_i - \overline{x} \sum_{i=1}^{n} y_i}{\sum_{i=1}^{n} x_i^2 - n\overline{x}^2}$$
(5)

After the best distribution is determined depending on value of the shape parameter, β , the second step (final step) is use to determine the distribution parameters by using Maximum Likelihood Estimator (MLE) as shown in table 2.

3.3 Result Comparison – Numerical Example

In this section, a set of failure times originally presented by Johnson (1964, p. 70) [3] was considered as a numerical example (table 3). The failure time is assumed as a complete data (not censored). The analysis results using both of traditional and a new approach are compared by using equations (1) to (5) and the calculation steps that have been discussed in the previous section. The analysis results between traditional approach and a new approach are summarized in table 4.

Table 3 - Failure Times Originally Presented By [3]

Failure time, t
112
213
250
484
500
572

Traditio	onal Jak	A new approach		
Distributi	Indo	Distributi	Shana	
Distributi	mue	Distributi	Shape	
on test	x of	on test	paramet	
	fit, r		er, β	
Exponent	0.814	Weibull	1.40	
ial	5			
Weibull	0.948	Shape parameter, β		
	2	characteristic		
Normal	0.921	$1 < \beta < 3 =$ Failure		
	7	time follow weibull		
Lognorm	0.910	distribution		
al	6			

Table 4 -	The	analysis	results	of	[°] Traditional Approach a	and
		A	New A	pp	oroach	

3.4 Discussion

The result from traditional approach shows the index of fit *r*, are tested for exponential, weibull, normal and lognormal distributions. The index of fit r, of exponential, weibull, normal and lognormal distribution test present the values of 0.8145, 0.9482, 0.9217, and 0.9106, respectively. The index of fit, r of weibull distribution shows higher value of 0.9482. Therefore, traditional approach concludes that the best fit failure distribution follows the weibull distribution. In the new approach result, the shape β , for weibull test is determined and the value of, β is 1.40. This result indicates that the best fit of the failure time (table 3) also follows the weibull distribution (refer to estimation of shape parameters, β in figure 2 – A new approach). The scale parameter, θ ' is calculated based on the table 2 formula, where, θ ' is 593.4. Both of traditional approach and the new approach shows a similar results, which the failure time (table 3) followed the weibull distribution. This result proved that the new approach proposed can be used as a practical technique in determining the best fit failure distribution.

4. Conclusion

In this paper, a new approach to determine the best fit distribution is proposed. The basic idea in the new approach is determine the shape parameters, β of weibull distribution test. From the shape parameters, β , the best fit distribution of failure time can be predicted. Numerical example showed a similar result for both of traditional approach and the new approach. Simpler calculation steps to determine the best fit distribution is the main advantages by using a new approach compared to traditional approach that used require more calculation steps. This new approach can assist engineers to reduce the time analysis and the result is valid for maintenance strategies purposes.

References

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Distribution	Parameter	Formula		
Exponential	Failure rate, λ'	$\lambda' = \frac{n}{\sum_{i=1}^{n} t_i}$	n = total number of failure time t = failure time	
			<i>i</i> = number of failure time	
Weibull	Shape parameter, β'	$\beta = \frac{\sum_{i=1}^{n} x_i y_i - \overline{x} \sum_{i=1}^{n} y_i}{\sum_{i=1}^{n} x_i^2 - n \overline{x}^2}$	$\beta = \beta'$ $n = \text{total number of}$ failure time $i = \text{number of failure}$ time	
	Scale parameter, θ'	$\boldsymbol{\theta}' = \left\{ \frac{1}{n} \left[\sum_{i=1}^{n} t_i^{\beta'} \right] \right\}^{\frac{1}{\beta'}}$	n = total number of failure time t = failure time i = number of failure time c = chere persenter	
Normal	Variance, $\sigma^{2'}$	$\sigma^2 = \frac{(n-1)\sigma^*}{n}$	$p = \text{snape parameter}$ $n = \text{ total number of}$ $failure time$ $\sigma^* = \text{variance from}$ sample	
	Mean, µ'	$\mu' = \sum \frac{t_i}{n} = \overline{x}$	$n = \text{total number of}$ $failure time$ $t = \text{failure time}$ $i = \text{number of failure}$ $time$ $\mu' = \text{mean, } \mu^* \text{ from}$ sample	
Lognormal	Mean, µ'	$\mu' = \sum_{i=1}^{n} \frac{\ln t_i}{n}$	n = total number of failure time t = failure time i = number of failure time	
	Standard deviation, σ '	$\sigma' = \sqrt{\frac{\sum_{i=1}^{n} (\ln t_i - \mu')^2}{n}}$	n = total number of failure time t = failure time i = number of failure time $\mu' = \text{mean}$	

Table 2 - Parameters and formula to estimate the parameters of each distribution

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